

Figure 2 - Pin Connections

Change Summary

Changes from the May 2005 issue to the September 2011 issue.

Page	Item	Change
1	Ordering Information	Removed leaded packages as per PCN notice.

Pin Description

Pin #		Name	Description
PDIP	PLCC		
1-3	1-3	Y2-Y0	Y2-Y0 Analog (Inputs/Outputs): these are connected to the Y2-Y0 columns of the switch array.
4	6	DATA	DATA (Input): a logic high input will turn on the selected switch and a logic low will turn off the selected switch. Active High.
5	7	X0	X0 Analog (Input/Output): this is connected to the X0 row of the switch array.
6	8	AX0	X0 Address Line (Input)
7	9	X1	X1 Analog (Input/Output): this is connected to the X1 row of the switch array.
8	10	AX1	X1 Address Line (Input)
9	11	X2	X2 Analog (Input/Output): this is connected to the X2 row of the switch array.
10	12	CS	Chip Select (Input): this is used to select the device. Active High.
11	13	X3	X3 Analog (Input/Output): this is connected to the X3 row of the switch array.
12	14	V _{SS}	Digital Ground Reference

Pin Description

Pin #		Name	Description
PDIP	PLCC		
13	15	V_{EE}	Negative Power Supply
14-16	16,17, 20	AY0-AY2	Y0 -Y2 Address Lines (Inputs)
17	21	STROBE	STROBE (Input): enables function selected by address and data. Address must be stable before STROBE goes high and DATA must be stable on the falling edge of the STROBE. Active High.
18	22	RESET	Master RESET (Input): this is used to turn off all switches regardless of the condition of CS. Active High.
19-23	23-27	Y7-Y3	Y7-Y3 Analog (Inputs/Outputs): these are connected to the Y7-Y3 columns of the switch array.
24	28	VDD	Positive Power Supply
	4, 5, 18, 19	NC	No Connect

Functional Description

The MT8806 is an analog switch matrix with an array size of 8 x 4. The switch array is arranged such that there are 8 columns by 4 rows. The columns are referred to as the Y inputs/outputs and the rows are the X inputs/outputs. The crosspoint analog switch array will interconnect any X I/O with any Y I/O when turned on and provide a high degree of isolation when turned off. The control memory consists of a 32 bit write only RAM in which the bits are selected by the address inputs (AY0-AY2, AX0 & AX1). Data is presented to the memory on the DATA input. Data is asynchronously written into memory whenever both the CS (Chip Select) and the STROBE inputs are high and is latched on the falling edge of STROBE. A logical "1" written into a memory cell turns the corresponding crosspoint switch on and a logical "0" turns the crosspoint off. Only the crosspoint switches corresponding to the addressed memory location are altered when data is written into memory. The remaining switches retain their previous states. Any combination of X and Y inputs/outputs can be interconnected by establishing appropriate patterns in the control memory. A logical "1" on the RESET input will asynchronously return all memory locations to logical "0" turning off all crosspoint switches regardless of whether CS is high or low. Two voltage reference pins (V_{SS} and V_{EE}) are provided for the MT8806 to enable switching of negative analog signals. The range for digital signals is from V_{DD} to V_{SS} while the range for analog signals is from V_{DD} to V_{EE} . V_{SS} and V_{EE} pins can be tied together if a single voltage reference is needed.

Address Decode

The five address inputs along with the STROBE and CS (Chip Select) inputs are logically ANDed to form an enable signal for the resettable transparent latches. The DATA input is buffered and is used as the input to all latches. To write to a location, RESET must be low and CS must go high while the address and data are set up. Then the STROBE input is set high and then low causing the data to be latched. The data can be changed while STROBE is high, however, the corresponding switch will turn on and off in accordance with the DATA input. DATA must be stable on the falling edge of STROBE in order for correct data to be written to the latch.

Absolute Maximum Ratings* - Voltages are with respect to V_{EE} unless otherwise stated.

	Parameter	Symbol	Min.	Max.	Units
1	Supply Voltage	V_{DD} V_{SS}	-0.3 -0.3	15.0 $V_{DD}+0.3$	V V
2	Analog Input Voltage	V_{INA}	-0.3	$V_{DD}+0.3$	V
3	Digital Input Voltage	V_{IN}	$V_{SS}-0.3$	$V_{DD}+0.3$	V
4	Current on any I/O Pin	I		± 15	mA
5	Storage Temperature	T_S	-65	+150	°C
6	Package Power Dissipation PLASTIC DIP	P_D		0.6	W

* Exceeding these values may cause permanent damage. Functional operation under these conditions is not implied.

Recommended Operating Conditions - Voltages are with respect to V_{EE} unless otherwise stated.

	Characteristics	Sym.	Min.	Typ.	Max.	Units	Test Conditions
1	Operating Temperature	T_O	-40	25	85	°C	
2	Supply Voltage	V_{DD} V_{SS}	4.5 V_{EE}		13.2 $V_{DD}-4.5$	V V	
3	Analog Input Voltage	V_{INA}	V_{EE}		V_{DD}	V	
4	Digital Input Voltage	V_{IN}	V_{SS}		V_{DD}	V	

DC Electrical Characteristics[†] - Voltages are with respect to $V_{EE}=V_{SS}=0V$, $V_{DD}=12V$ unless otherwise stated.

	Characteristics	Sym.	Min.	Typ. [‡]	Max.	Units	Test Conditions
1	Quiescent Supply Current	I_{DD}		1	100	μA	All digital inputs at $V_{IN}=V_{SS}$ or V_{DD}
				0.4	1.5	mA	All digital inputs at $V_{IN}=2.4 + V_{SS}$; $V_{SS}=7.0V$
				5	15	mA	All digital inputs at $V_{IN}=3.4V$
2	Off-state Leakage Current (See G.9 in Appendix)	I_{OFF}		± 1	± 500	nA	$ V_{Xi} - V_{Yj} = V_{DD} - V_{EE}$ See Appendix, Fig. A.1
3	Input Logic "0" level	V_{IL}			$0.8+V_{S_s}$	V	$V_{SS}=7.5V$; $V_{EE}=0V$
4	Input Logic "1" level	V_{IH}	$2.0+V_{SS}$			V	$V_{SS}=6.5V$; $V_{EE}=0V$
5	Input Logic "1" level	V_{IH}	3.3			V	
6	Input Leakage (digital pins)	I_{LEAK}		0.1	10	μA	All digital inputs at $V_{IN} = V_{SS}$ or V_{DD}

[†] DC Electrical Characteristics are over recommended temperature range.

[‡] Typical figures are at 25°C and are for design aid only; not guaranteed and not subject to production testing.

DC Electrical Characteristics- Switch Resistance - V_{DC} is the external DC offset applied at the analog I/O pins.

	Characteristics	Sym.	25°C		70°C		85°C		Units	Test Conditions
			Typ.	Max.	Typ.	Max.	Typ.	Max.		
1	On-state Resistance $V_{DD}=12V$ $V_{DD}=10V$ $V_{DD}=5V$ (See G.1, G.2, G.3 in Appendix)	R_{ON}	45 55 120	65 75 185		75 85 215		80 90 225	Ω Ω Ω	$V_{SS}=V_{EE}=0V, V_{DC}=V_{DD}/2$, $ V_{Xi}-V_{Yj} = 0.4V$ See Appendix, Fig. A.2
2	Difference in on-state resistance between two switches (See G.4 in Appendix)	ΔR_{ON}	5	10		10		10	Ω	$V_{DD}=12V, V_{SS}=V_{EE}=0$, $V_{DC}=V_{DD}/2$, $ V_{Xi}-V_{Yj} = 0.4V$ See Appendix, Fig. A.2

AC Electrical Characteristics[†] - Crosspoint Performance - Voltages are with respect to $V_{DD}=5V, V_{SS}=0V, V_{EE}=-7V$, unless otherwise stated.

	Characteristics	Sym.	Min.	Typ. [‡]	Max.	Units	Test Conditions
1	Switch I/O Capacitance	C_S		20		pF	$f=1\text{ MHz}$
2	Feedthrough Capacitance	C_F		0.2		pF	$f=1\text{ MHz}$
3	Frequency Response Channel "ON" $20\text{LOG}(V_{OUT}/V_{Xi})=-3\text{dB}$	$F_{3\text{dB}}$		45		MHz	Switch is "ON"; $V_{INA} = 2V_{pp}$ sinewave; $R_L = 1k\Omega$ See Appendix, Fig. A.3
4	Total Harmonic Distortion (See G.5, G.6 in Appendix)	THD		0.01		%	Switch is "ON"; $V_{INA} = 2V_{pp}$ sinewave $f=1\text{ kHz}$; $R_L=1k\Omega$
5	Feedthrough Channel "OFF" Feed. $=20\text{LOG}(V_{OUT}/V_{Xi})$ (See G.8 in Appendix)	FDT		-95		dB	All Switches "OFF"; $V_{INA}=2V_{pp}$ sinewave; $f=1\text{ kHz}$; $R_L=1k\Omega$ See Appendix, Fig. A.4
6	Crosstalk between any two channels for switches X_i-Y_i and X_j-Y_j . $X_{\text{talk}}=20\text{LOG}(V_{Yj}/V_{Xi})$. (See G.7 in Appendix).	X_{talk}		-45		dB	$V_{INA}=2V_{pp}$ sinewave $f=10\text{ MHz}$; $R_L=75\Omega$
				-90		dB	$V_{INA}=2V_{pp}$ sinewave $f=10\text{ kHz}$; $R_L=600\Omega$
				-85		dB	$V_{INA}=2V_{pp}$ sinewave $f=10\text{ kHz}$; $R_L=1k\Omega$
				-80		dB	$V_{INA}=2V_{pp}$ sinewave $f=1\text{ kHz}$; $R_L=10k\Omega$ Refer to Appendix, Fig. A.5 for test circuit.
7	Propagation delay through switch	t_{PS}			30	ns	$R_L=1k\Omega; C_L=50\text{ pF}$

[†] Timing is over recommended temperature range. See Fig. 3 for control and I/O timing details.

[‡] Typical figures are at 25°C and are for design aid only; not guaranteed and not subject to production testing.

Crosstalk measurements are for Plastic DIPs only, crosstalk values for PLCC packages are approximately 5 dB better.

AC Electrical Characteristics[†] - Control and I/O Timings- Voltages are with respect to $V_{DD}=5V$, $V_{SS}=0V$, $V_{EE}=-7V$, unless otherwise stated.

	Characteristics	Sym.	Min.	Typ. [‡]	Max.	Units	Test Conditions
1	Control Input crosstalk to switch (for CS, DATA, STROBE, Address)	CX_{talk}		30		mVpp	$V_{IN}=3V$ squarewave; $R_{IN}=1k\Omega$, $R_L=10k\Omega$ See Appendix, Fig. A.6
2	Digital Input Capacitance	C_{DI}		10		pF	$f=1MHz$
3	Switching Frequency	F_O			20	MHz	
4	Setup Time DATA to STROBE	t_{DS}	10			ns	$R_L=1k\Omega$, $C_L=50pF$ Δ
5	Hold Time DATA to STROBE	t_{DH}	10			ns	$R_L=1k\Omega$, $C_L=50pF$ Δ
6	Setup Time Address to STROBE	t_{AS}	10			ns	$R_L=1k\Omega$, $C_L=50pF$ Δ
7	Hold Time Address to STROBE	t_{AH}	10			ns	$R_L=1k\Omega$, $C_L=50pF$ Δ
8	Setup Time CS to STROBE	t_{CSS}	10			ns	$R_L=1k\Omega$, $C_L=50pF$ Δ
9	Hold Time CS to STROBE	t_{CSH}	10			ns	$R_L=1k\Omega$, $C_L=50pF$ Δ
10	STROBE Pulse Width	t_{SPW}	20			ns	$R_L=1k\Omega$, $C_L=50pF$ Δ
11	RESET Pulse Width	t_{RPW}	40			ns	$R_L=1k\Omega$, $C_L=50pF$ Δ
12	STROBE to Switch Status Delay	t_S		40	100	ns	$R_L=1k\Omega$, $C_L=50pF$ Δ
13	DATA to Switch Status Delay	t_D		50	100	ns	$R_L=1k\Omega$, $C_L=50pF$ Δ
14	RESET to Switch Status Delay	t_R		35	100	ns	$R_L=1k\Omega$, $C_L=50pF$ Δ

[†] Timing is over recommended temperature range. See Fig. 3 for control and I/O timing details.

Digital Input rise time (t_r) and fall time (t_f) = 5 ns.

[‡] Typical figures are at 25°C and are for design aid only; not guaranteed and not subject to production testing.

Δ Refer to Appendix, Fig. A.7 for test circuit.

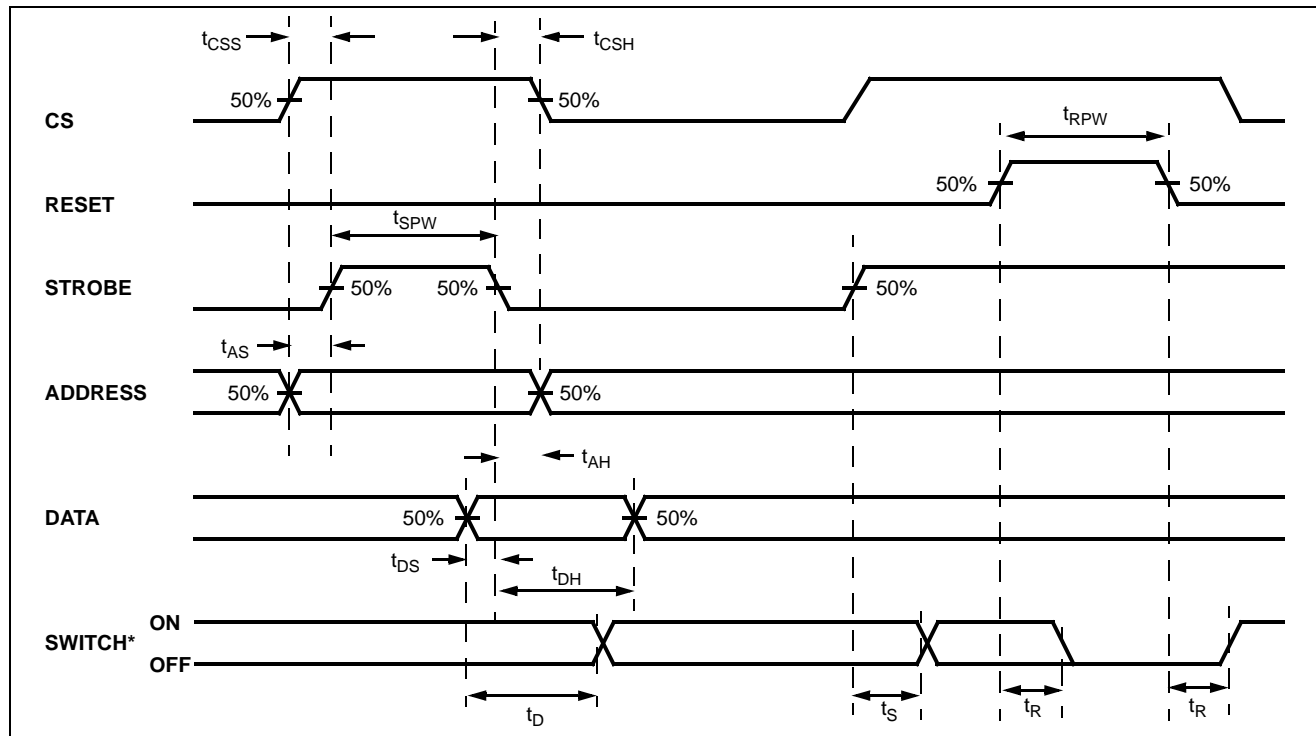
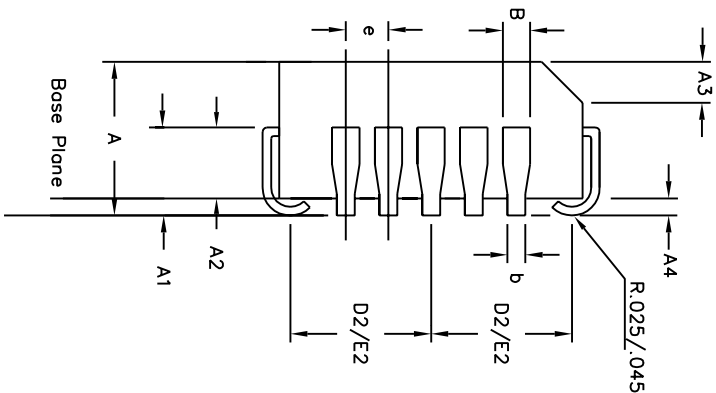
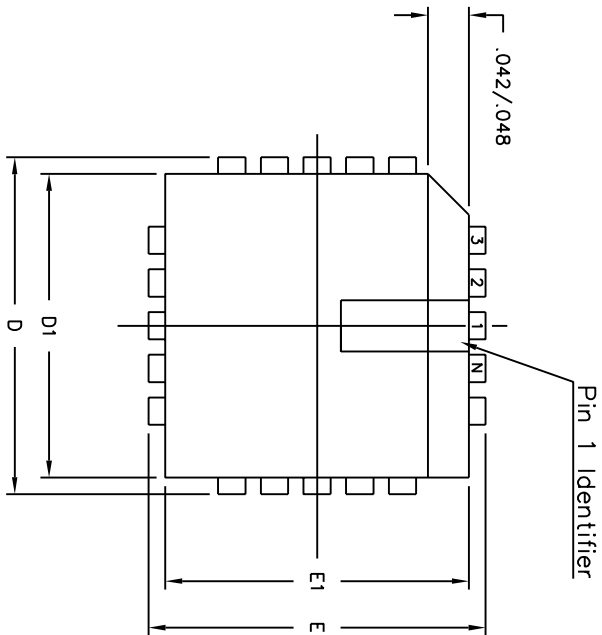


Figure 3 - Control Memory Timing Diagram

* See Appendix, Fig. A.7 for switching waveform

AX0	AX1	AY0	AY1	AY2	Connection
0	0	0	0	0	X0-Y0
0	0	1	0	0	X0-Y1
0	0	0	1	0	X0-Y2
0	0	1	1	0	X0-Y3
0	0	0	0	1	X0-Y4
0	0	1	0	1	X0-Y5
0	0	0	1	1	X0-Y6
0	0	1	1	1	X0-Y7
1 ↓ 1	0 ↓ 0	0 ↓ 1	0 ↓ 1	0 ↓ 1	X1-Y0 ↓ X1-Y7
0 ↓ 0	1 ↓ 1	0 ↓ 1	0 ↓ 1	0 ↓ 1	X2-Y0 ↓ X2-Y7
1 ↓ 1	1 ↓ 1	0 ↓ 1	0 ↓ 1	0 ↓ 1	X3-Y0 ↓ X3-Y7

Table 1 - Address Decode Truth Table



Symbol	Control Dimensions in inches		Altern. Dimensions in millimetres	
	MIN	MAX	MIN	MAX
A	0.165	0.180	4.19	4.57
A1	0.090	0.120	2.29	3.05
A2	0.062	0.083	1.57	2.11
A3	0.042	0.056	1.07	1.42
A4	0.020	—	0.51	—
D	0.485	0.495	12.32	12.57
D1	0.450	0.456	11.43	11.58
D2	0.191	0.219	4.85	5.56
E	0.485	0.495	12.32	12.57
E1	0.450	0.456	11.43	11.58
E2	0.191	0.219	4.85	5.56
B	0.026	0.032	0.66	0.81
b	0.013	0.021	0.33	0.53
e	0.050	BSC	1.27	BSC
Pin features				
ND	7			
NE	7			
N	28			
Note	Square			
Conforms to JEDEC MS-018AB Iss. A				

Seating Plane

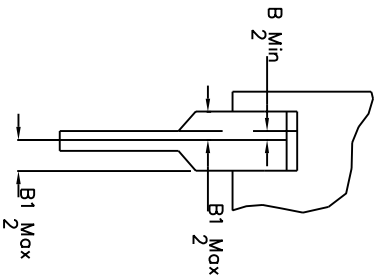
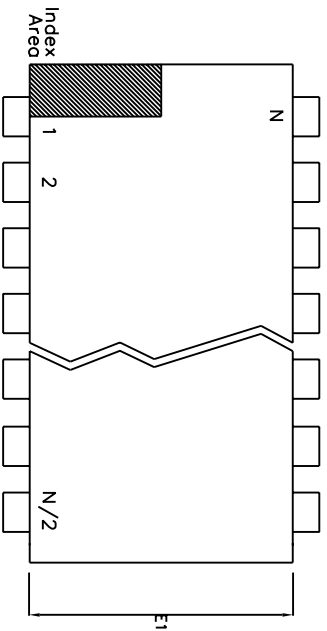
- Notes:
1. All dimensions and tolerances conform to ANSI Y14.5M-1982
 2. Dimensions D1 and E1 do not include mould protrusions. Allowable mould protrusion is 0.010" per side. Dimensions D1 and E1 include mould protrusion mismatch and are determined at the parting line, that is D1 and E1 are measured at the extreme material condition at the upper or lower parting line.
 3. Controlling dimensions in inches.
 4. "N" is the number of terminals.
 5. Not To Scale
 6. Dimension R required for 120° minimum bend.

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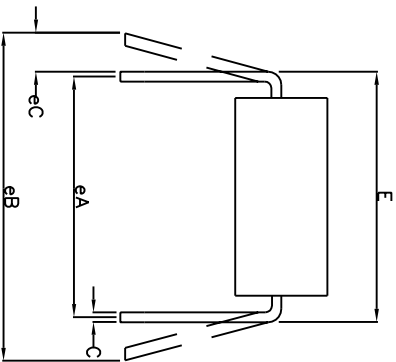
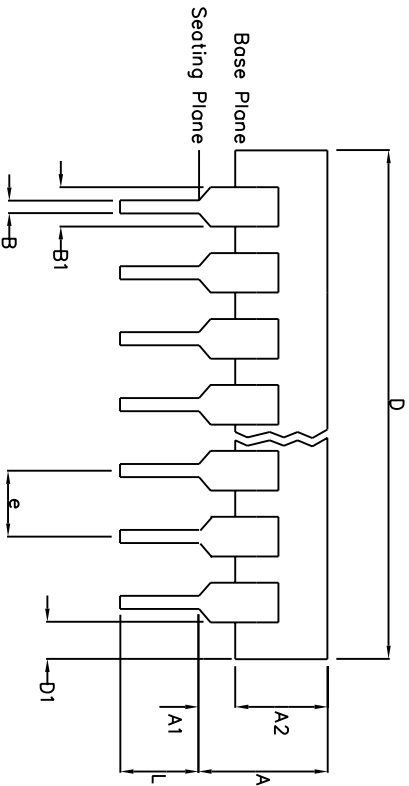


Previous package codes		Package Code	QA
HP / P		Package Outline for 28 lead PLCC	
		GPD000002	



	Min	Max	Min	Max
	mm	mm	inches	inches
A		6.35		0.250
A1	0.38		0.015	
A2	3.18	4.95	0.125	0.195
B	0.36	0.56	0.014	0.022
B1	0.76	1.78	0.030	0.070
C	0.20	0.38	0.008	0.015
D	29.21	32.77	1.150	1.290
D1	0.13		0.005	
E	15.24	15.88	0.600	0.625
E1	12.32	14.73	0.485	0.580
e	2.54	BSC	0.100	BSC
eA	15.24	BSC	0.600	BSC
eB		17.78		0.700
L	2.92	5.08	0.115	0.200
N		24		24

Conforms to Jeduc MS-011AA ISS.B



- Notes:
1. Controlling Dimensions are in inches
 2. Dimension A, A1 and L are measured with the package seated in the Seating Plane
 3. Dimensions D & E1 do not include mould flash or protrusions. Mould flash or protrusion shall not exceed 0.010 inch.
 4. Dimensions E & eA are measured with leads constrained to be perpendicular to plane 1.
 5. Dimensions eB & eC are measured at the lead tips with the leads unconstrained; eC must be zero or greater.

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Previous package codes	Package Code
DP / E	DA
	Package Outline for 24 lead PDIP

CPD000071



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